

Key concepts and Goals

- Chemical background
- Many techniques can be used for analysis of ceramics and glass
 - PIXE, PIGE, EBA, ICP-OES, SEM-EDX, Petrography
- Non-destructive Elemental Analysis
 - X-ray Fluorescence (XRF) Spectroscopy
- Non-destructive Molecular Analysis
 - X-ray Diffraction
 - Fourier Transform Infrared Spectroscopy (FTIR)
 - Raman Spectroscopy





Glass and Ceramic

- Amorphous or Crystalline?
- What is the composition?
- What is chemical changes may influence composition or surface vs. bulk?
- What do you need to know for conservation?
- Bulk vs. Inclusions vs. Surface?





Glass and Deterioration

 initial stage, incipient crizzling, full-blown crizzling, advanced, crizzling and fragmentation stages





Jerzy J. Kunicki-Goldfinger (2008) Unstable historic glass: symptoms, causes, mechanisms and conservation, Studies in Conservation, 53:sup2, 47-60, DOI: 10.1179/ sic_2008.53.Supplement-2.47

Material and Chemical Properties

- Cermaics and Glass have low porosity and similar density
- Porcelain: porcelian-clay, flux and filler + glaze
 - Typically quartz, mica, feldspar, kaolin
 - Variations include Spanish clays (high Mg)
- · Glass: silica, flux
- · Multilayered?
- Many different recipes, additives, lime, alkali metals, bone, talc

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Elements typically found in glass and ceramics

- Oxides of:
 - Na, Mg, Al, Si, P, K, Ca, Ti, Mn, Fe, Sn, Pb





X-Ray Fluorescence (XRF) Spectroscopy

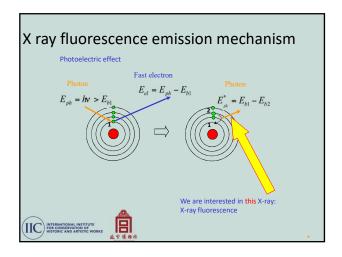
- Suitable as it yields elemental information about raw materials, processing techniques, and physical properties
- · Provenance/authenticity
- Note: beam size is large, compared to microscopic techniques (SEM-EDX)

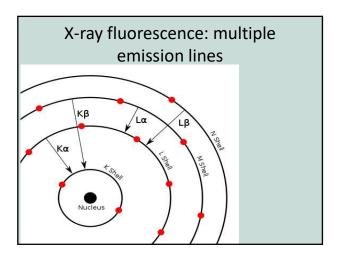


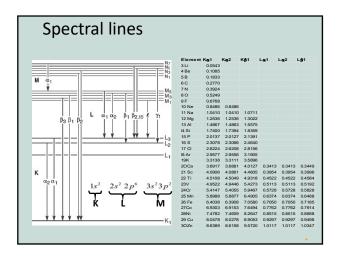


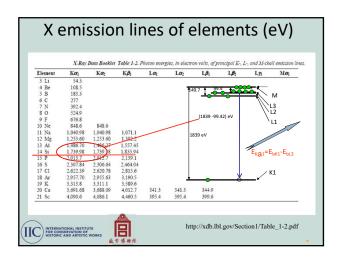
Theoretical Background: XRF

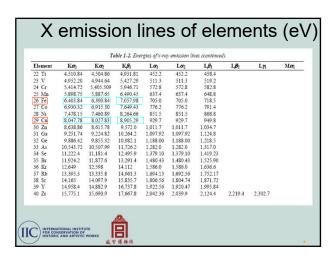
- A **low power** X ray beam is delivered to the sample
- Every chemical element in the sample emits characteristic X
 -rays give a fingerprint of the element
- An energy sensitive detector measures the energy spectrum of the emitted X rays
- The analysis of the peaks of the X fluorescence spectrum allows the detection of elements contained in the sample
 - In portable detectors (Silicon Drift Detectors), especially useful for the analysis of cultural heritage, the lighter detectable atom is usually sodium 11Na
- The limit of detection of lighter elements is given by the presence of Ar in air and by the entrance window of the detector, which is usually made of a low atomic number element (Be)

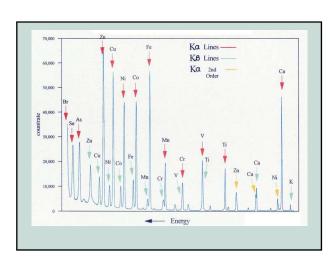


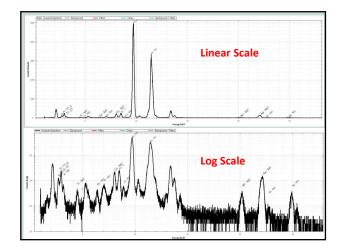








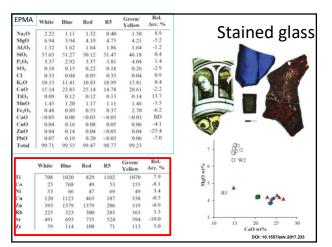


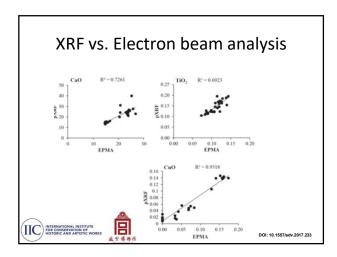


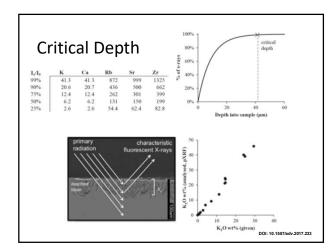
Glazes and Enamels

- Elements may suggest different additives or opacifiers and include:
 - Sb, Sn, Pb, Zn, As (modern Zr)
 - Naples Yellow (Pb, Sb) or Lead-tin yellows (Pb, Sn)
 - Hematite (Fe)
 - Cobalt (Co) and Fe/Zn/Mn









Critical: Depth resolution

- Multi-layered samples vs. Bulk
- Depth of penetration of X-rays
- Attenuation of photons in glaze, that depends on glaze composition
- Glaze may account for K lines of Mg-Fe
 - Lime-alkali glazes have Ca/(Na+K) >1
 - Alkali-lime have Ca/(Na+K)<1
- Glazes containing Pb (L line) can be easily detected
- With thick glaze layers, signals from Rb, Sr, Y and Zr are from bulk

Critical: Trace elements

- XRF for trace element analysis is complicated by the different penetration of X-rays, attenuation of emitted photons, and intrinsic limitations of instrumentation and detection
- Still for glass Zr, Rb and Sr are most useful in classifying glasses
- Careful optimisation of instrumentation to collect data from bulk and trace elements may be needed (especially for samples that are thinner than critical depth of analysis)

Useful quotation

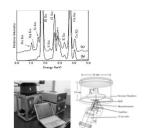
- When pXRF is used without the benefit of sampling for laboratory analysis, it will be difficult to interpret glass types without the major element concentrations and it will be impossible to compare to other published data without a database of trace elements
- The analysis of trace elements by pXRF provides a way to study the different sources of glass and glassmaking technology, and to identify nonoriginal glass





DOI: 10.1557/adv.2017.2

Case study: pXRF (vacuum) and Roman Glass



Vacuum 500 Pa → light element detection MOXTEK AP3.3 polymer window (vs. Conventional Barium) → light element detection, Pd source @ 40 kV

Na₂O content ranges mainly between 14 and 22 wt%,



X-Ray Spectrom. 2009. 38. 121–12

Critical Aspects: Calibration standards

- Calibration standards are needed for the quantification of concentrations of different elements in ceramics and glasses
 - Light vs. Heavy elements
- Quantification requires comparision between XRF and complementary (ICP-OES) techniques
 - Many glass standards are available for calibration
 - Fewer porcelain standards

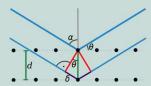




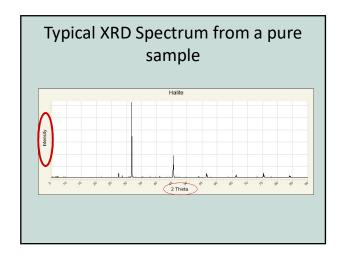
Phase Analysis: X-ray Diffraction

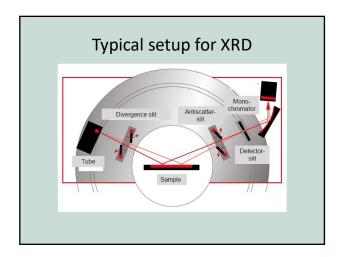
- Diffraction of crystalline materials is extremely powerful for material identification
- Based on Bragg's Law:

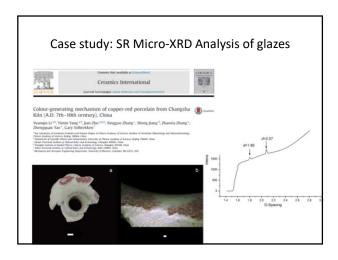
 $n \lambda = 2 d \sin \theta$



For Cubic systems TERNATIONAL INSTITUTE WITENATIONAL INSTITUTE LA THERMATIONAL INSTITUTE LA THERMA







Case Study: Western Han Dynasty **RESEARCH ARTICLE** A technological combination of lead-glaze and calcium-glaze recently found in China: Scientific comparative analysis of glazed ceramics from Shangyu, Zhejiang Province Yue Wang, Yhang Zhou, Zhefeng Yang, Jakafeng Culo ** **Booted & Achinacking on Manadage, Plang Unionely, Beign, Choa ***CASEARCH STATE OF THE CONTROLL OF T

XRD: a key to understanding firing temperature

- Co Source, voltage: 30kV, current: 300uA Angle range: 5°-55° (2θ), step: 0.04°(2θ).
- The formation of mullite requires a temperature higher than 1200°C, which means the samples No.19 and 24 were fired at a high temperature. The firing temperature of the sample No. 04 and 23 are much lower since no mullite signal was detected

No.	Sample group	Quartz	Ratife	Mullita
04	Medium-lead	86.1	8.1	
19	Low-lead	72.2		21.2
23	High-lead	85.5	8.9	
24	Medium-lead	67.3		24.9



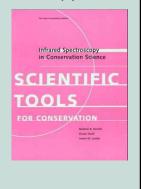


DOI:10.1371/journal.pone.0219608.g003

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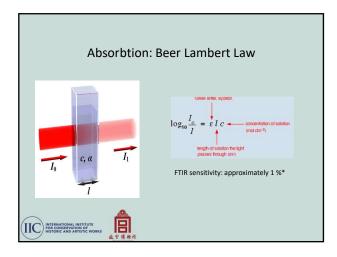
Vibrational Spetroscopy

- Common technique used for the analysis of inorganic and organic materials
- A very powerful tools for the assessment of degradation and conservation materials
- In IR absorption, frequencies which match the natural vibrational frequencies of molecules may be absorbed
- In Raman spectroscopy, frequencies which match vibrational frequencies may be scattered



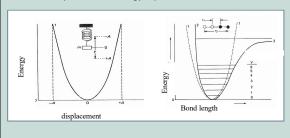
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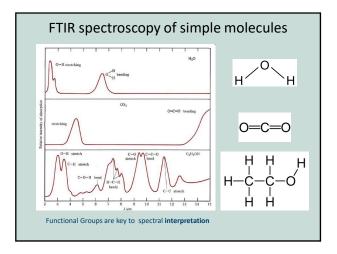


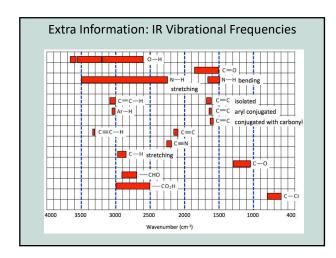


Simple model of infrared absorption

- In molecules, the chemical bond exerts an elastic force between atoms
- Absorption takes place only for discrete frequencies that correspond to the energy separation of vibrational levels

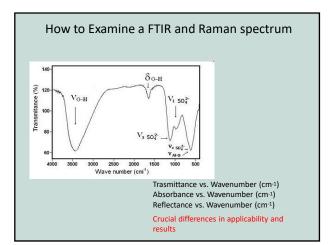


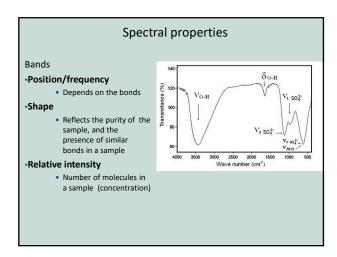






Band, cm-1	Assignment
3435	Absorbed water
1632	H-O-H str.
1082	Si-O-Si, SiO str.
1175	Si-O-Si str.
797	Si-O sym.str.
778	Si-O sym. str.
694	Si-O of SiO ₄ sym. bend
516	Si-O-Al asym. bend.
475	Si-O-Si asym. bend.



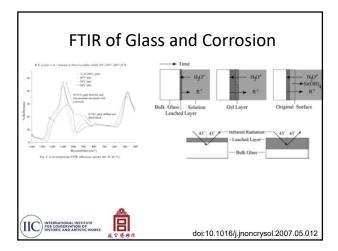


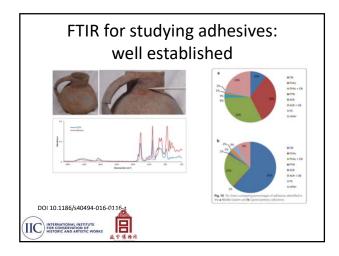
Reflectance Analysis • Specular Reflection (smooth

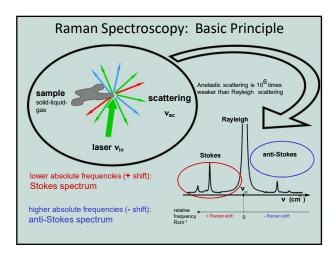
- surfaces)
 - measurement of thin layers or monolayers
 - coatings
- Diffuse Reflection (DRIFTs) (rough surfaces)
 - structural information is from the bulk matrix

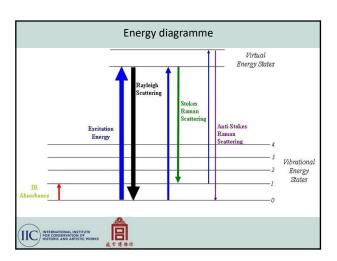


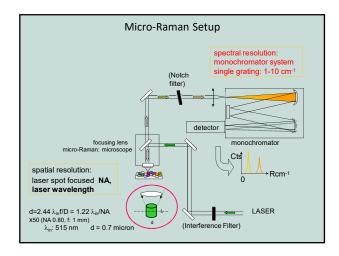












Complexity of Raman Spectroscopy: Experimental Parameters

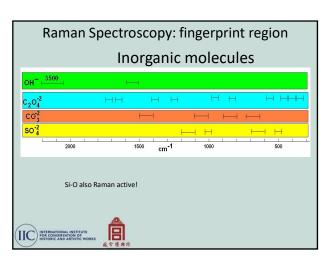
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LASER RADIATION AVOID DIRECT EYE EXPOSURI

DIODE LASER

5 mW MAX OUTPUT at 670 nm CLASS IIIa LASER PRODUCT

- Spectral Resolution (grating, laser)
- Spectral Range
- Calibration
- Number of acquisitions
- Time for each acquisition
- Laser parameters:
 - Wavelength
 - · Power density
 - Fluence (energy/ spot size)
- Microscope parameters
 - Magnification, focal distance, aberrations

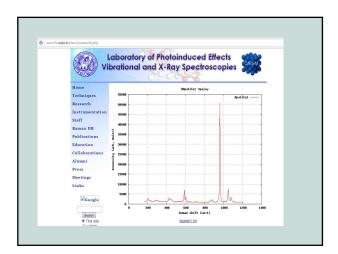


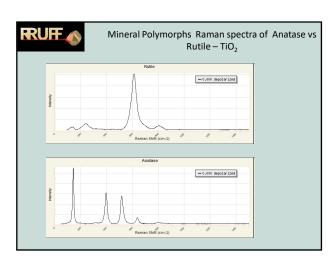
Spectral databases: Raman and XRD

- -Base de données de spectres Raman (La Société Française de Minéralogie et Cristallographie) (la SFMC)
- -Handbook of Minerals Raman Spectra (ENS-Lyon)
- -Integrated database of Raman spectra, X-ray diffraction and chemistry data for minerals (RRUFF Project)
- -Mineral Raman Database (University of Parma) —Raman Spectra Database of Minerals and Inorganic Materials (RASMIN) (Ceramics Inst. AIST)
- -Raman Spectra of Carbohydrates (Royal Vet. & Agric. Univ.)
- -Raman Spectroscopic Library of Natural and Synthetic Pigments (Univ. College London)
- -IRUG Database

Minerals:

-http://rruff.info/





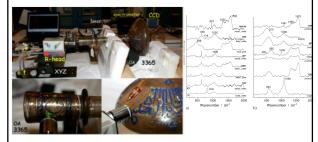
Raman Spectroscopy

- Pigments and colourants
- Variation in intensity of bending and stretching bands based on composition and degradation
- Si-O-Si bonds have strong signals at 500 and 1000 cm⁻¹ (broader in glassy structures), and the ratio of these bands has been used to classify the polymerisation (see Colomban)

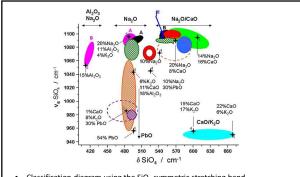




Case study: Raman Spectroscopy of Egyptian glass



P. Colomban et al , JRS, 2012



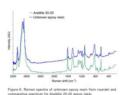
 Classification diagram using the SiO₄ symmetric stretching band wavenumber (vs) versus the bending (8) for a large glass corpus. Red circle and blue F correspond to Mamluk and 19th century (OA 7352 foot) glass.
 Representative compositions for the different areas are given (stars).

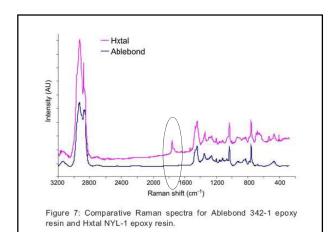
P. Colomban et al , JRS, 2012

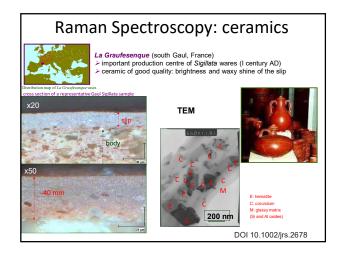


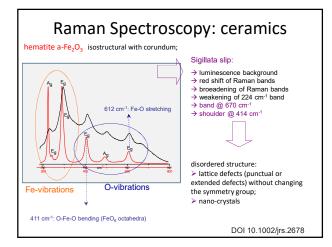
Experimental Parameters

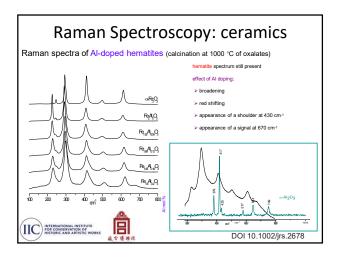
- PerkinElmer Raman Flex 400F with a 3 m fibre
- Laser (diode) 785 nm maximum power 300 mW at the laser source, 100 mW at the sample)
- Spectra acquired with a resolution of 2 cm⁻¹ from 200-3200 Raman Shift
- Distance from sample: 100 μm
- Acquistion time: 5 to 100 s











Classification based on Si vibrations/firing temperatures

X-ray diffraction and microprobe analysis revealed systematic differences between the central Italian (Arezzo) and south Gaul productions (La Graufesenque), both in the elemental and mineral compositions,[6–8] All the signs contain quartz and hematite: however, the Sallic ones embody a significant content of corundum nanocrystals, while the Italian productions contained a great proportion of spinel (MgALQ-Q). In addition, the X-ray diffraction study of the mineral composition of the body indicates that the Italian syillator was fired at lower temperatures than the Gallic ones.

Conclusions

- Non-destructive Elemental Analysis
 - X-ray Fluorescence (XRF) Spectroscopy:
 - Heavy vs. Light elements
- Non-destructive Molecular Analysis
 - Fourier Transform Infrared Spectroscopy
 - Corrosion products, organic materials
 - Raman Spectroscopy
 - Different glass signatures, glaze composition, organic materials
 - X-ray Diffraction
 - Phase information, firing temperature



